

RF Exposure Report

Report No.: SA160222E03

FCC ID: QISAF61

Test Model: AF61

Received Date: Feb. 22, 2016

Test Date: Mar. 09, 2016

Issued Date: Mar. 31, 2016

Applicant: Huawei Technologies Co., Ltd.

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Issued By: Bureau Veritas Consumer Products Services (H.K.) Ltd., Taoyuan Branch
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Release Control Record

Issue No.	Description	Date Issued
SA160222E03	Original release.	Mar. 31, 2016

1 Certificate of Conformity

Product: MatePen

Brand: HUAWEI

Test Model: AF61

Sample Status: ENGINEERING SAMPLE

Applicant: Huawei Technologies Co.,Ltd.

Test Date: Mar. 09, 2016

Standards: FCC Part 2 (Section 2.1093)

KDB 447498 D01 General RF Exposure Guidance v06

ANSI/ IEEE C95.1-1992

The above equipment has been tested by **Bureau Veritas Consumer Products Services (H.K.) Ltd., Taoyuan Branch**, and found compliance with the requirement of the above standards. The test record, data evaluation & Equipment Under Test (EUT) configurations represented herein are true and accurate accounts of the measurements of the sample's EMC characteristics under the conditions specified in this report.

Prepared by :



Date:

Mar. 31, 2016

Elsie Hsu / Specialist

Approved by :



Date:

Mar. 31, 2016

May Chen / Manager

2 Evaluation Result

Following FCC KDB 447498 D01 "General SAR test exclusion guidance"

The corresponding SAR Exclusion Threshold condition, listed below:

- 1) The 1-g and 10-g SAR test exclusion thresholds for 100 MHz to 6 GHz at test separation distances ≤ 50 mm are determined by:

$$[(\text{max. power of channel, including tune-up tolerance, mW})/(\text{min. test separation distance, mm})] \cdot [\sqrt{f(\text{GHz})}]$$

$$\leq 3.0 \text{ for 1-g SAR and } \leq 7.5 \text{ for 10-g extremity SAR, where}$$
 - $f(\text{GHz})$ is the RF channel transmit frequency in GHz.
 - Power and distance are rounded to the nearest mW and mm before calculation.
 - The result is rounded to one decimal place for comparison. The test exclusions are applicable only when the minimum test separation distance is ≤ 50 mm and for transmission frequencies between 100 MHz and 6 GHz. When the minimum test separation distance is < 5 mm, a distance of 5 mm is applied to determine SAR test exclusion.
- 2) At 100 MHz to 6 GHz and for test separation distances > 50 mm, the SAR test exclusion threshold is determined according to the following:
 - a) [Threshold at 50 mm in step 1) + (test separation distance - 50mm) · ($f(\text{MHz})/150$)] mW, at 100MHz to 1500 MHz
 - b) [Threshold at 50 mm in step 1) + (test separation distance - 50 mm) · 10] mW at > 1500 MHz and ≤ 6 GHz
- 3) At frequencies below 100 MHz, the following may be considered for SAR test exclusion.
 - a) The threshold at the corresponding test separation distance at 100 MHz in step 2) is multiplied by $[1 + \log(100/f(\text{MHz}))]$ for test separation distances > 50 mm and < 200 mm.
 - b) The threshold determined by the equation in a) for 50 mm and 100 MHz is multiplied by $\frac{1}{2}$ for test separation distances ≤ 50 mm.
 - c) SAR measurement procedures are not established below 100 MHz. When SAR test exclusion cannot be applied, a KDB inquiry is required to determine SAR evaluation requirements for any test results to be acceptable.

3 Antenna Gain

1. The antenna provided to the EUT, please refer to the following table:

Brand	Model	Antenna Gain(dBi)	Frequency range (GHz to GHz)	Antenna Type	Connector Type
Unictron	H2U34WGTQW0100	2.5	2.4~2.4835	Chip	none (like solder)

4 SAR Test Exclusion Thresholds

Frequency (GHz)	Max. Power (mW)	Min. test separation distance (mm)	SAR test exclusion calculation value ^(NOTE 2)	10-g extremity SAR test exclusion thresholds	Result
2.402 ~ 2.480	3.162	5	0.98784038	7.5	Pass

NOTE: 1. The antenna type is Chip antenna with 2.5dBi gain.
2. Calculate SAR test exclusion thresholds from condition "1" formulas.
3. This power include tune-up tolerance range that specified in AF61 Tune Up power table

5 Conclusion

Since Source-base time average power is below SAR test exclusion power thresholds, the SAR evaluation is not required.

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